

Low-threshold Coherently-coupled Organic VCSEL

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Here we report observation of extremely low-threshold lasing in organic VCSELs when the excitons are coherently coupled non-radiatively to each other. Non-radiative coupling between excitons can enhance the emission cross-section of a gain material and lead to laser action at considerably lower excitation densities [1]. The coupling strength associated with the excitonic interaction is proportional to the number of excited molecules at any given time; hence the effect necessitates creating the exciton population quickly relative to the excited state decay time. This phenomenon is often referred to as superradiance [1], [2]. In organic semiconductor VCSELs, this effect leads to a 95% reduction in threshold when sub-ps non-resonant excitation is utilized to create the exciton population, instead of a longer nsec duration pump pulse. The VCSELs consist of a thermally evaporated gain layer composed of the laser dye DCM doped (2.5 % v/v) into an Alq₃ host matrix, which is situated between a metal mirror and a dielectric Bragg reflector (DBR). In VCSELs where the gain layer is “ $\lambda/2n$ thick”, i.e., 156.7 nm, an extremely low threshold of 4.9 $\mu\text{J}/\text{cm}^2$ is observed. This marks the first time lasing from organics has been reported in a metal/DBR half-wavelength thick microcavity, despite the rather modest resonator quality factor of $Q < 200$. Lasing is confirmed by supra-linear input-output power dependence and by spectral and spatial line-narrowing above the threshold. Moreover, when the optical excitation is polarized, the emission above the threshold strongly follows the polarization of the pump light. All prior demonstrations of laser action in solid-state organic VCSEL structures have utilized either gain layers of at least 3 times the thickness [3] or have relied on higher finesse of all dielectric microcavities [4]. The observed laser threshold of 4.9 $\mu\text{J}/\text{cm}^2$ in the half-wavelength thick microcavity corresponds to excitation of at most 3.2% of the DCM molecules.

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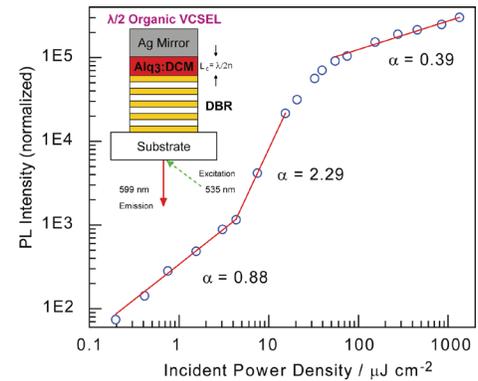


FIGURE 1: Input/Output power dependence upon direct DCM excitation ($\lambda_{ex} = 535 \text{ nm}$) shows the lasing threshold at 4.9 $\mu\text{J}/\text{cm}^2$ incident power and superlinear slope $\alpha = 2.29$ when fit to power law, $y = mx^\alpha$. Inset: Device design consists of a dielectric Bragg reflector (DBR), organic semiconductor gain layer, and silver mirror. The sample is excited at $q = 60^\circ$ from normal using TM polarized laser light focused down to a spot size of 0.001 cm^2 as measured on the sample plane.

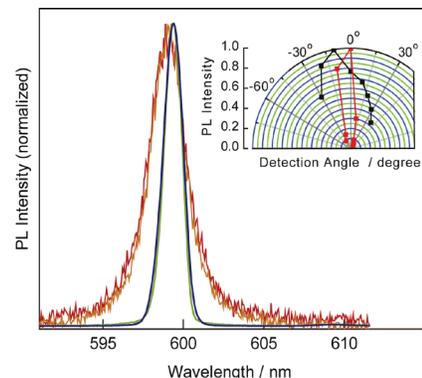


FIGURE 2: Emission spectra of OVCSEL at different power levels above and below the threshold show linewidth narrowing from 2.5 nm for excitation below threshold (red, 3.25 $\mu\text{J}/\text{cm}^2$; orange, 8 $\mu\text{J}/\text{cm}^2$) to 1.1 nm above threshold (green, 15 $\mu\text{J}/\text{cm}^2$; blue, 250 $\mu\text{J}/\text{cm}^2$). Inset: Emission cone spatially narrows from from $Dq = \pm 30^\circ$ to $Dq = \pm 5^\circ$ as measured at the emission peak.